

- ★ Green Device
- ★ Super Low Gate
- ★ Excellent CdV/dt effect decline
- ★ Advanced high cell density Trench technology
- ★ 100% EAS Guaranteed

## **Product Summary**



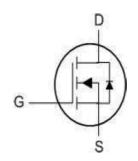
BVDSS	RDSON	ID
60V	28mΩ	20A

#### Description

The 20N06D is the high cell density trenched N-ch MOSFETs, which provides excellent RDSON and and gate charge for most of the synchronous buck converter applications. The 20N06D meets the RoHS and Green Product requirement 100% EAS guaranteed with full function reliability approved.

#### PDFN3\* 3 Pin Configuration





## **Package Marking and Ordering Information**

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
20N06	20N06	PDFN3*3			5000

#### **Absolute Maximum Ratings**

Symbol	Parameter	Value	Unit
Vos	Drain-Source Voltage	60	V
Vgs	Gate-Source Voltage	±20	V
Ib@Tc=25°C	Continuous Drain Current, Vcs @ 10V <sup>1</sup>	20	А
In@Tc=100°C	Continuous Drain Current, Vcs @ 10V <sup>1</sup>	10	А
Ірм	Pulsed Drain Current₂	46	Α
EAS	Single Pulse Avalanche Energy <sup>3</sup>	25.5	mJ
<b>I</b> AS	Avalanche Current	20	Α
Pd@Ta=25°C	Total Power Dissipation₄	34.7	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
T <sub>J</sub>	Operating Junction Temperature Range	-55 to 150	°C

#### **Thermal Data**

Symbol Parameter		Тур.	Max.	Unit
Reja	Thermal Resistance Junction-Ambient 1		62	°C/W



## Electrical Characteristics (T<sub>J</sub> =25 °C unless otherwise specified)

Symbol	Parameter	Test condition	Min.	Тур.	Max.	Units
Off Characte	Off Characteristic					
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	Vgs=0V, lp=250µA	60	-	-	V
loss	Zero Gate Voltage Drain Current	V <sub>DS</sub> =60V, V <sub>GS</sub> = 0V,	-	-	1	μΑ
lgss	Gate to Body Leakage Current	$V_{DS}=0V$ , $V_{GS}=\pm20V$	-	-	±100	nA
On Character	ristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	Vos=Vgs, lo=250µA	1	1.6	2.5	V
Dno( )	Static Drain-Source on-Resistance notes	Vgs=10V, lp=5A	-	28	40	mΩ
RDS(on)	Static Dialii-Source off-Nesistance notes	Vgs=4.5V, lp=3A	-	36	50	
Dynamic Cha	racteristics					
Ciss	Input Capacitance	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V,	-	1148	-	pF
Coss	Output Capacitance	f=1.0MHz	-	58.5	-	pF
Crss	Reverse Transfer Capacitance	II-I.UIVII IZ	-	49.4	-	рF
Qg	Total Gate Charge	VDS=30V, ID=2.5A,	-	20.3	-	nC
Qgs	Gate-Source Charge	VDS=30V, ID=2.5A, VGS=10V	-	3.7	-	nC
Qgd	Gate-Drain("Miller") Charge	VGS=1UV	-	5.3	-	nC
Switching Ch	aracteristics					
td(on)	Turn-on Delay Time		-	7.6	-	ns
tr	Turn-on Rise Time	Vps=30V, lp=5A,	-	20	-	ns
td(off)	Turn-off Delay Time	R <sub>G</sub> =1.8Ω, V <sub>G</sub> s=10V	-	15	-	ns
tf	Turn-off Fall Time		-	24	-	ns
Drain-Source	Diode Characteristics and Max	imum Ratings				
ls	Maximum Continuous Drain to Source D	iode Forward Current	-	-	5	Α
lsм	Maximum Pulsed Drain to Source Diode Forward Current		-	-	20	Α
Vsp	Drain to Source Diode Forward Voltage	V <sub>G</sub> s=0V, I <sub>S</sub> =5A	-	-	1.2	V
trr	Body Diode Reverse Recovery Time	l⊧=5A, dl/dt=100A/μs	-	29	-	ns
Qrr	Body Diode Reverse Recovery Charge	·	-	43		nC

- 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
- 2. EAS condition :  $T_J$ =25°C, $V_{DD}$ =30V, $V_G$ =10V,L=0.5mH,Rg=25 $\Omega$ ,IAS=8.7Å
- 3. Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%



## Typical Electrical and Thermal Characteristics (Curves)

## Figure 1: Output Characteristics

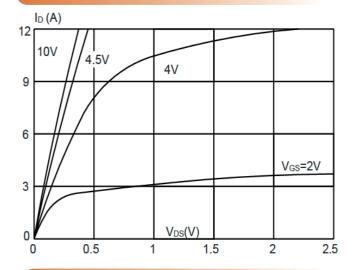


Figure 3:On-resistance vs. Drain Current

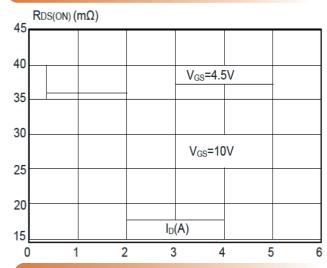


Figure 5: Gate Charge Characteristics

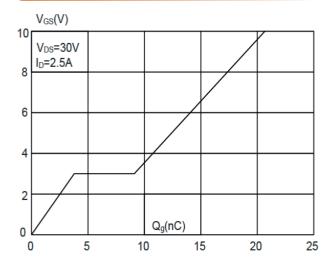


Figure 2: Typical Transfer Characteristic

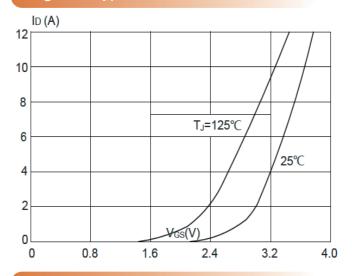


Figure 4: Body Diode Characteristics

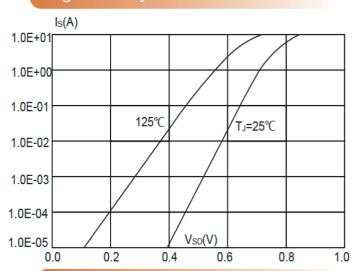
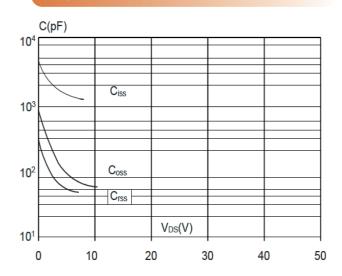


Figure 6:Capacitance Characteristics





#### **Typical Performance Characteristics**

# Figure 7: Normalized Breakdown Voltag

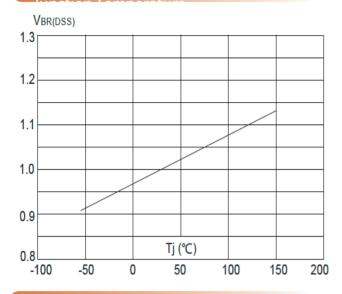


Figure 9: Maximum Safe Operating Area

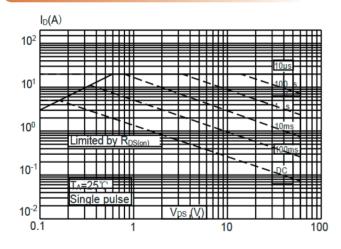
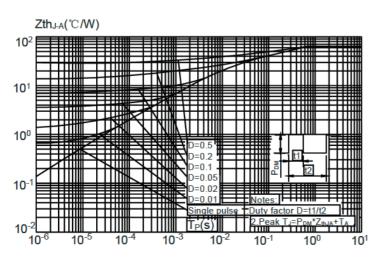


Figure 10:Maximum Effective



# Figure 8: Normalized on Resistance vs

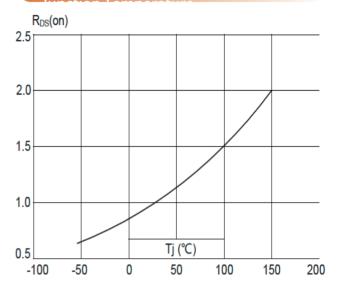
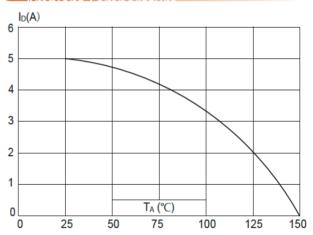


Figure 11:Maximum Continuous Drain C





## **Test Circuit**

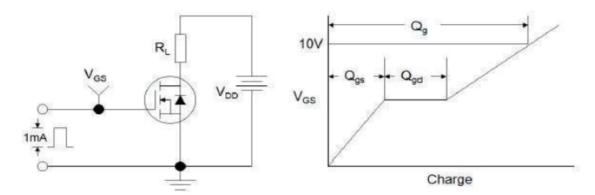


Figure1:Gate Charge Test Circuit & Waveform

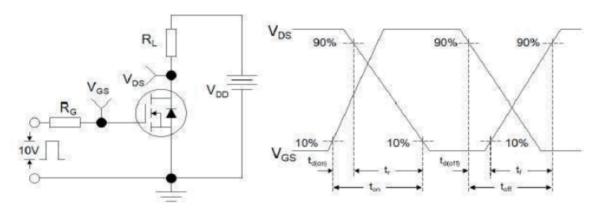


Figure 2: Resistive Switching Test Circuit & Waveforms

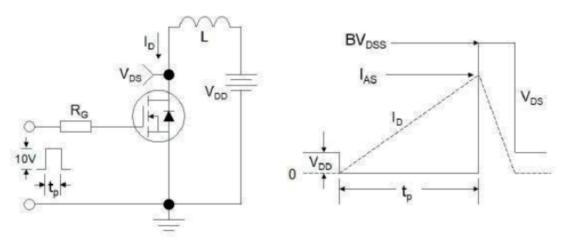
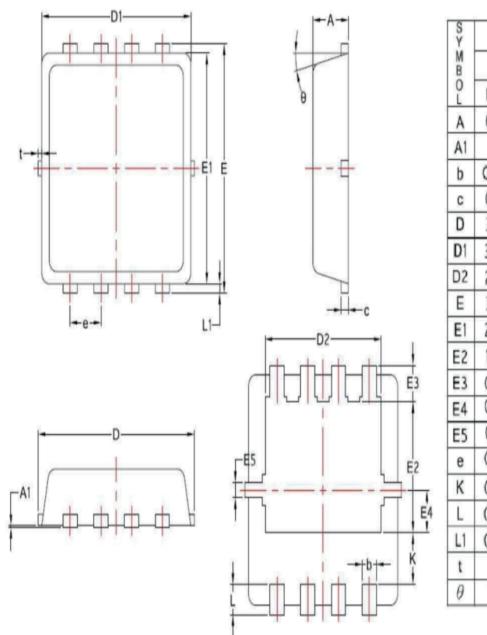


Figure 3:Unclamped Inductive Switching Test Circuit & Waveforms



## Package Mechanical Data- PDFN3.3X3.3-8L



S	COMMON				
M B O L	MM				
0	MIN	NOM	MAX		
Α	0.70	0.75	0.85		
A1	/	/	0.05		
b	0.20	0.30	0.40		
С	0.10	0.152	0.25		
D	3.15	3.30	3.45		
D1	3.00	3.15	3.25		
D2	2.29	2.45	2.65		
Е	3.15	3.30	3.45		
E1	2.90	3.05	3.20		
E2	1.54	1.74	1.94		
E3	0.28	0.48	0.65		
E4	0.37	0.57	0.77		
E5	0.10	0.20	0.30		
е	0.60	0.65	0.70		
K	0.59	0.69	0.89		
L	0.30	0.40	0.50		
L1	0.06	0.125	0.20		
t	0	0.075	0.13		
θ	10°	12°	14°		